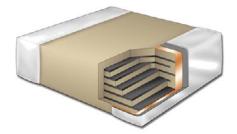


Overview

KEMET's Ceramic Open Mode capacitor in X7R dielectric is designed to significantly minimize the probability of a low IR or short circuit condition when forced to failure in a board stress flex situation, thus reducing the potential for catastrophic failure. The Open Mode capacitor may experience a drop in capacitance; however, a short is unlikely because a crack will not typically propagate across counter electrodes within the device's "active area." Since there will not be any current leakage associated with a typical Open Mode flex crack, there is no localized heating and therefore little chance for a catastrophic and potentially costly failure event.

Driven by the demand for a more robust and reliable component, the Open Mode capacitor was designed for critical applications where higher operating temperatures and mechanical stress are a concern. These capacitors are widely used in automotive circuits as well as power supplies (input and output filters) and general electronic applications. Concerned with flex cracks resulting from excessive tensile and shear stresses produced during board flexure and thermal cycling? These devices are available with KEMET's Flexible termination technology which inhibits the transfer of board stress to the rigid ceramic body, therefore mitigating flex cracks which can result in low IR or short circuit failures. Although flexible termination technology does not eliminate the potential for mechanical damage that may propagate during extreme environmental and handling conditions, it does provide superior flex performance over standard termination systems. When combined with flexible termination technology these devices offer the ultimate level of protection against a low IR or short circuit condition. Open Mode devices compliment KEMET's Floating Electrode (FE-CAP) and Floating Electrode with Flexible Termination (FF-CAP) product lines by providing a fail-safe design optimized for mid to high range capacitance values. These devices exhibit a predictable change in capacitance with respect to time and voltage and boast a minimal change in capacitance with reference to ambient temperature. Capacitance change is limited to $\pm 15\%$ from -55° C to $\pm 125^{\circ}$ C.



Ordering Information

С	1210	J	685	К	3	R	А	С	TU
Ceramic	Case Size (L" x W")	Specification/ Series	Capacitance Code (pF)	Capacitance Tolerance	Voltage	Dielectric Failure Rate Design		Termination Finish ¹	Packaging/Grade (C-Spec) ²
	0805 1206 1210 1812	•	2 Significant Digits + Number of Zeros		4 = 16 V 3 = 25 V 5 = 50 V 1 = 100 V 2 = 200 V	R = X7R	A = N/A	C = 100% Matte Sn L = SnPb (5% minimum)	Blank = Bulk TU = 7" Reel Unmarked TM = 7" Reel Marked AUTO = Automotive Grade

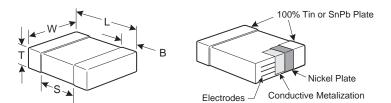
¹ Additional termination finish options may be available. Contact KEMET for details.

^{1,2} SnPb termination finish option is not available on automotive grade product.

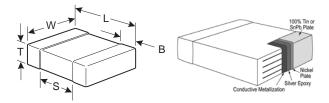
² Additional reeling or packaging options may be available. Contact KEMET for details.



Dimensions – Millimeters (Inches) – Standard Termination



EIA Size Code	Metric Size Code	L Length	W Width	T Thickness	B Bandwidth	S Separation Minimum	Mounting Technique
0805	2012	2.00 (.079) ± 0.20 (.008)	1.25 (.049) ± 0.20 (.008)		0.50 (0.02) ± 0.25 (.010)	0.75 (.030)	Solder Wave or
1206	3216	3.20 (.126) ± 0.20 (.008)	1.60 (.063) ± 0.20 (.008)	See Table 2 for	0.50 (0.02) ± 0.25 (.010)		Solder Reflow
1210	3225	3.20 (.126) ± 0.20 (.008)	2.50 (.098) ± 0.20 (.008)	Thickness	0.50 (0.02) ± 0.25 (.010)	N/A	Calder Dafley, Only
1812	4532	4.50 (.177) ± 0.30 (.012)	3.20 (.126) ± 0.30 (.012)		0.60 (.024) ± 0.35 (.014)		Solder Reflow Only



Dimensions – Millimeters (Inches) – Flexible Termination

EIA Size Code	Metric Size Code	L Length	W Width	T Thickness	B Bandwidth	S Separation Minimum	Mounting Technique
0805	2012	2.00 (.079) ± 0.20 (.008)	1.25 (.049) ± 0.20 (.008)		0.50 (0.02) ± 0.25 (.010)	0.75 (.030)	Solder Wave or
1206	3216	3.30 (.130) ± 0.40 (.016)	1.60 (.063) ± 0.20 (.008)	See Table 2 for	0.60 (.024) ± 0.25 (.010)		Solder Reflow
1210	3225	3.30 (.130) ± 0.40 (.016)	2.50 (.098) ± 0.20 (.008)	Thickness	0.60 (.024) ± 0.25 (.010)	N/A	Solder Reflow
1812	4532	4.50 (.178) ± 0.40 (.016)	3.20 (.126) ± 0.30 (.012)		0.70 (.028) ± 0.35 (.014)		Only

Benefits

- -55°C to +125°C operating temperature range
- Open Mode/fail open design
- Mid to high capacitance flex mitigation
- Pb-Free and RoHS Compliant
- EIA 0805, 1206, 1210, and 1812 case sizes
- + DC voltage ratings of 16 V, 25 V, 50 V, 100 V, and 200 V
- Capacitance offerings ranging from 1,000 pF to 6.8 μF
- Available capacitance tolerances of ±5%, ±10%, and ±20%

- · Non-polar device, minimizing installation concerns
- 100% pure matte tin-plated termination finish allowing for excellent solderability
- · Commercial and Automotive (AEC-Q200) grades available
- SnPb termination finish option available upon request (5% minimum)
- Flexible termination option available upon request



Applications

Typical applications include input side filtering (power plane/bus), high current (battery line) and circuits that cannot be fused to open when short circuits occur due to flex cracks. Markets include automotive applications that are directly connected to the battery and/or involve conversion to a 42 V system and raw power input side filtering in power conversion.

Qualification/Certification

Commercial Grade products are subject to internal qualification. Details regarding test methods and conditions are referenced in Table 4, Performance and Reliability.

Automotive Grade products meet or exceed the requirements outlined by the Automotive Electronics Council. Details regarding test methods and conditions are referenced in document AEC–Q200, Stress Test Qualification for Passive Components. For additional information regarding the Automotive Electronics Council and AEC–Q200, please visit their website at www.aecouncil.com.

Environmental Compliance

Pb-Free and RoHS Compliant (excluding SnPb termination finish option).



Electrical Parameters/Characteristics

Item	Parameters/Characteristics
Operating Temperature Range	-55°C to +125°C
Capacitance Change with Reference to +25°C and 0 VDC Applied (TCC)	±15%
Aging Rate (Maximum % Capacitance Loss/Decade Hour)	3.0%
Dielectric Withstanding Voltage (DWV)	250% of rated voltage (5 ±1 seconds and charge/discharge not exceeding 50 mA)
Dissipation Factor (DF) Maximum Limit @ 25°C	5% (6.3 and 10 V), 3.5% (16 and 25 V) and 2.5% (50 to 250 V)
Insulation Resistance (IR) Limit @ 25°C	See Insulation Resistance Limit Table (Rated voltage applied for 120 ±5 seconds @ 25°C)

Regarding aging rate: Capacitance measurements (including tolerance) are indexed to a referee time of 1,000 hours.

To obtain IR limit, divide $M\Omega$ - μ F value by the capacitance and compare to $G\Omega$ limit. Select the lower of the two limits.

Capacitance and dissipation factor (DF) measured under the following conditions:

1 kHz ±50 Hz and 1.0 ±0.2 Vrms if capacitance \leq 10 μF

120 Hz ±10Hz and 0.5 ±0.1 Vrms if capacitance > 10 μ F

Note: When measuring capacitance it is important to ensure the set voltage level is held constant. The HP4284 and Agilent E4980 have a feature known as Automatic Level Control (ALC). The ALC feature should be switched to "ON."



Post Environmental Limits

	High Temperature Life, Biased Humidity, Moisture Resistance											
Dielectric	Rated DC Voltage	Capacitance Value	Dissipation Factor (Maximum %)	Capacitance Shift	Insulation Resistance							
	> 25		3.0									
X7R	16/25	All	5.0	±20%	10% of Initial Limit							
	< 16		7.5									

Insulation Resistance Limit Table (X7R Dielectric)

EIA Case Size	1,000 Megohm Microfarads or 100 GΩ	500 Megohm Microfarads or 10 GΩ
0201	N/A	ALL
0402	< 0.012 µF	≥ 0.012 µF
0603	< 0.047 µF	≥ 0.047 µF
0805	< 0.047 µF	≥ 0.047 µF
1206	< 0.22 µF	≥ 0.22 µF
1210	< 0.39 µF	≥ 0.39 µF
1808	ALL	N/A
1812	< 2.2 µF	≥ 2.2 µF
1825	ALL	N/A
2220	< 10 µF	≥ 10 µF
2225	ALL	N/A



Table 1 – Capacitance Range/Selection Waterfall (0805 – 1812 Case Sizes)

		Ser	ies		С	0805	δF			С	:1206	F			С	1210	F			C18	12F	
0	Сар	Voltag	e Code	4	3	5	1	2	4	3	5	1	2	4	3	5	1	2	3	5	1	2
Capacitance	Code	Volta	qe DC	16	25	50	100	200	16	25	50	100	200	16	25	50	100	200	25	50	100	200
			itance ance					F			/ailab e 2 fo							S	I			
1,000 pF	102	K	М	DD	DD	DD	DD	DD														
1,200 pF	122	K	M	DD	DD	DD	DD	DD														
1,500 pF	152	K	M	DD	DD	DD	DD	DD														
1,800 pF	182	K	M	DD	DD	DD	DD	DD														
2,200 pF	222	K	M	DD	DD	DD	DD	DD														
2,700 pF	272	K	M	DD	DD	DD	DD	DD														
3,300 pF	332	K	M	DD	DD	DD	DD	DD														
3,900 pF	392 472	K K	M M	DD DD	DD DD	DD DD	DD DD	DD DD														
4,700 pF 5,600 pF	472 562	ĸ	M	DD	DD	DD		DD														
6,800 pF	682	K	M	DD	DD	DD	DD	DD														
8,200 pF	822	K	M	DD	DD	DD	DD	DD														
10,000 pF	103	K	M	DD	DD	DD	DD	DD														
12,000 pF	123	K	M	DD	DD	DD	DD	DG														
15,000 pF	153	K	M	DD	DD	DD	DD	DG														
18,000 pF	183	K	M	DD	DD	DD	DD	50	EC	EC	EC	EC	EC									
22,000 pF	223	K	M	DD	DD	DD	DG		EC	EC	EC	EC	EC									
27,000 pF	273	K	M	DD	DD	DD	DG		EC	EC	EC	EC	EC									
33,000 pF	333	K	M	DD	DD	DD	DG		EC	EC	EC	EC	EC									
39,000 pF	393	К	М	DD	DD	DD	DG		EC	EC	EC	EC	EC									
47,000 pF	473	K	М	DD	DD	DD	DE		EC	EC	EC	EC	EG						GB	GB	GB	GB
56,000 pF	563	K	М	DD	DD	DD			EC	EC	EC	EC	EG						GB	GB	GB	GB
68,000 pF	683	K	М	DD	DD	DG	DG		EC	EC	EC	EC	EG	FD	FD	FD	FD	FD	GB	GB	GB	GB
82,000 pF	823	K	М	DD	DD	DG			EC	EC	EC	EC	EG	FD	FD	FD	FD	FD	GB	GB	GB	GB
0.10 µF	104	K	М	DG	DG	DG			EC	EC	EC	EC	EG	FD	FD	FD	FD	FG	GB	GB	GB	GB
0.12 µF	124	K	М	DG	DG				EC	EC	EC	EC		FD	FD	FD	FD	FG	GB	GB	GB	GB
0.15 µF	154	K	М	DG	DG				EC	EC	EC	EG		FD	FD	FD	FD	FH	GB	GB	GB	GB
0.18 µF	184	K	М	DG	DG				EC	EC	EC	EG		FD	FD	FD	FD	FH	GB	GB	GB	GB
0.22 µF	224	K	М	DG	DD	DG			EC	EC	EC	ED		FD	FD	FD	FG	FJ	GB	GB	GB	GC
0.27 µF	274	K	М	DD	DD				EC	EC	EC			FD	FD	FD	FG		GB	GB	GB	GF
0.33 µF	334	K	М	DD	DG				EG	EG	EG	EG		FD	FD	FD	FH		GB	GB	GB	GK
0.39 µF	394	K	М	DD	DG				EG	EG				FD	FD	FG	FH		GB	GB	GB	GL
0.47 µF	474	K	М	DE	DG				EG	EG	EC			FD	FD	FG	FJ		GB	GB	GC	
0.56 µF	564	K	M						EG					FD	FD	FG	FR		GB	GB	GD	
0.68 µF	684	K	M	DG					EG					FD	FG	FH	FR		GD	GD	GF	
0.82 µF	824	K	M						EG	F 0				FD	FG	FH	FR		GD	GD	GK	
1.0 µF	105	K	M						EG	EC	EH			FD FG	FH	FJ	FS		GN	GN	GM	
1.2 µF	125 155	K K	M											FG								
1.5 μF 1.8 μF	155 185	K K	M											FH								
1.8 μF 2.2 μF	225	K	M						EC	EH				FH	FM	FM						
2.2 μF 2.7 μF	225	K	M						LC					15	1 IVI	1 IVI						
3.3 µF	335	K	IVI											FM								
3.9 µF	395	K	М																			
4.7 μF	475	K	M						EH					FG	FM				GK	GK		
6.8 µF	685	K	M											FS	FS							
r			ge DC	16	25	50	100	200	16	25	50	100	200	16	25	50	100	200	25	50	100	200
Capacitance	Cap Code	Voltag	e Code	4	3	5	1	2	4	3	5	1	2	4	3	5	1	2	3	5	1	2
		Ser	ies		C	:0805	F			C	1206	F			C	:1210	F			C18	312F	



Thickness	Case	Thickness ±	Paper C	Quantity	Plastic (Quantity	
Code	Size	Range (mm)	7" Reel	13" Reel	7" Reel	13" Reel	
DD	0805	0.90 ± 0.10	4,000	10,000	0	0	
DE	0805	1.00 ± 0.10	0	0	2,500	10,000	
DG	0805	1.25 ± 0.15	0	0	2,500	10,000	
EC	1206	0.90 ± 0.10	0	0	4,000	10,000	
ED	1206	1.00 ± 0.10	0	0	2,500	10,000	
EG	1206	1.60 ± 0.15	0	0	2,000	8,000	
EH	1206	1.60 ± 0.20	0	0	2,000	8,000	
FD	1210	0.95 ± 0.10	0	0	4,000	10,000	
FG	1210	1.25 ± 0.15	0	0	2,500	10,000	
FH	1210	1.55 ± 0.15	0	0	2,000	8,000	
FM	1210	1.70 ± 0.20	0	0	2,000	8,000	
FJ	1210	1.85 ± 0.20	0	0	2,000	8,000	
FR	1210	2.25 ± 0.20	0	0	2,000	8,000	
FS	1210	2.50 ± 0.20	0	0	1,000	4,000	
GB	1812	1.00 ± 0.10	0	0	1,000	4,000	
GC	1812	1.10 ± 0.10	0	0	1,000	4,000	
GD	1812	1.25 ± 0.15	0	0	1,000	4,000	
GF	1812	1.50 ± 0.10	0	0	1,000	4,000	
GK	1812	1.60 ± 0.20	0	0	1,000	4,000	
GN	1812	1.70 ± 0.20	0	0	1,000	4,000	
GL	1812	1.90 ± 0.20	0	0	500	2,000	
GM	1812	2.00 ± 0.20	0	0	500	2,000	
Thickness	Case	Thickness ±	7" Reel	13" Reel	7" Reel	13" Reel	
Code	Size	Range (mm)	Paper G	Plastic (Plastic Quantity		

Table 2 – Chip Thickness/Packaging Quantities

Package quantity based on finished chip thickness specifications.

Table 3A – Land Pattern Design Recommendations per IPC–7351 – Standard Termination

EIA Size Code	Metric Size Code	Density Level A: Maximum (Most) Land Protrusion (mm)					Density Level B: Median (Nominal) Land Protrusion (mm)					Density Level C: Minimum (Least) Land Protrusion (mm)				
oouc	oode	С	Y	Х	V1	V2	С	Y	Х	V1	V2	С	Y	Х	V1	V2
0805	2012	1.00	1.35	1.55	4.40	2.60	0.90	1.15	1.45	3.50	2.00	0.75	0.95	1.35	2.80	1.70
1206	3216	1.60	1.35	1.90	5.60	2.90	1.50	1.15	1.80	4.70	2.30	1.40	0.95	1.70	4.00	2.00
1210	3225	1.60	1.35	2.80	5.65	3.80	1.50	1.15	2.70	4.70	3.20	1.40	0.95	2.60	4.00	2.90
1210 ¹	3225	1.50	1.60	2.90	5.60	3.90	1.40	1.40	2.80	4.70	3.30	1.30	1.20	2.70	4.00	3.00
1812	4532	2.15	1.60	3.60	6.90	4.60	2.05	1.40	3.50	6.00	4.00	1.95	1.20	3.40	5.30	3.70

¹ Only for capacitance values \geq 22 μ F

Density Level A: For low-density product applications. Recommended for wave solder applications and provides a wider process window for reflow solder processes. KEMET only recommends wave soldering of EIA 0603, 0805 and 1206 case sizes.

Density Level B: For products with a moderate level of component density. Provides a robust solder attachment condition for reflow solder processes.

Density Level C: For high component density product applications. Before adapting the minimum land pattern variations the user should perform qualification testing based on the conditions outlined in IPC Standard 7351 (IPC–7351).



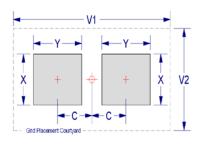
Table 3B – Land Pattern Design Recommendations per IPC–7351 – Flexible Termination

EIA Size Code	Metric Size Code	Density Level A: Maximum (Most) Land Protrusion (mm)						Media	sity Lev an (Nor rotrusic)	Density Level C: Minimum (Least) Land Protrusion (mm))
oouc	oode	С	Y	Х	V1	V2	С	Y	Х	V1	V2	С	Y	Х	V1	V2
0805	2012	1.00	1.35	1.55	4.40	2.60	0.90	1.15	1.45	3.50	2.00	0.80	0.95	1.35	2.80	1.70
1206	3216	1.60	1.65	1.90	5.90	2.90	1.50	1.45	1.80	5.00	2.30	1.40	1.25	1.70	4.30	2.00
1210	3225	1.60	1.65	2.80	5.90	3.80	1.50	1.45	2.70	5.00	3.20	1.40	1.25	2.60	4.30	2.90
1812	4532	2.10	0 1.80 3.60 7.00 4.60			2.00	1.60	3.50	6.10	4.00	1.90	1.40	3.40	5.40	3.70	

Density Level A: For low-density product applications. Recommended for wave solder applications and provides a wider process window for reflow solder processes. KEMET only recommends wave soldering of EIA 0603, 0805 and 1206 case sizes.

Density Level B: For products with a moderate level of component density. Provides a robust solder attachment condition for reflow solder processes.

Density Level C: For high component density product applications. Before adapting the minimum land pattern variations the user should perform qualification testing based on the conditions outlined in IPC Standard 7351 (IPC–7351).



Soldering Process

Recommended Soldering Technique:

Solder wave or solder reflow for EIA case sizes 0603, 0805 and 1206

• All other EIA case sizes are limited to solder reflow only

Recommended Soldering Profile:

• KEMET recommends following the guidelines outlined in IPC/JEDEC J-STD-020



Table 4 – Performance & Reliability: Test Methods and Conditions

Stress	Reference	Test or Inspection Method
Terminal Strength	JIS-C-6429	Appendix 1, Note: Force of 1.8 kg for 60 seconds.
Board Flex	JIS-C-6429	Appendix 2, Note: Standard termination system – 2.0 mm (minimum) for all except 3 mm for C0G. Flexible termination system – 3.0 mm (minimum).
		Magnification 50 X. Conditions:
Solderability	J-STD-002	a) Method B, 4 hours @ 155°C, dry heat @ 235°C
Solderability	J-31D-002	b) Method B @ 215°C category 3
		c) Method D, category 3 @ 260°C
Temperature Cycling	JESD22 Method JA-104	1,000 Cycles (-55°C to +125°C). Measurement at 24 hours +/- 2 hours after test conclusion.
Discolutionsidity		Load Humidity: 1,000 hours 85°C/85% RH and rated voltage. Add 100 K ohm resistor. Measurement at 24 hours +/- 2 hours after test conclusion.
Biased Humidity	MIL-STD-202 Method 103	Low Volt Humidity: 1,000 hours 85°C/85% RH and 1.5 V. Add 100 K ohm resistor. Measurement at 24 hours +/- 2 hours after test conclusion.
Moisture Resistance	MIL-STD-202 Method 106	t = 24 hours/cycle. Steps 7a and 7b not required. Unpowered. Measurement at 24 hours +/- 2 hours after test conclusion.
Thermal Shock	MIL-STD-202 Method 107	-55°C/+125°C. Note: Number of cycles required – 300, maximum transfer time – 20 seconds, dwell time – 15 minutes. Air – Air.
High Temperature Life	MIL-STD-202 Method 108 /EIA-198	1,000 hours at 125°C (85°C for X5R, Z5U and Y5V) with 2 X rated voltage applied.
Storage Life	MIL-STD-202 Method 108	150°C, 0 VDC for 1,000 hours.
Vibration	MIL-STD-202 Method 204	5 g's for 20 min., 12 cycles each of 3 orientations. Note: Use 8" X 5" PCB 0.031" thick 7 secure points on one long side and 2 secure points at corners of opposite sides. Parts mounted within 2" from any secure point. Test from 10 – 2,000 Hz
Mechanical Shock	MIL-STD-202 Method 213	Figure 1 of Method 213, Condition F.
Resistance to Solvents	MIL-STD-202 Method 215	Add aqueous wash chemical, OKEM Clean or equivalent.

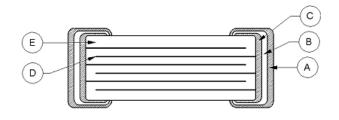
Storage and Handling

Ceramic chip capacitors should be stored in normal working environments. While the chips themselves are quite robust in other environments, solderability will be degraded by exposure to high temperatures, high humidity, corrosive atmospheres, and long term storage. In addition, packaging materials will be degraded by high temperature– reels may soften or warp and tape peel force may increase. KEMET recommends that maximum storage temperature not exceed 40°C and maximum storage humidity not exceed 70% relative humidity. Temperature fluctuations should be minimized to avoid condensation on the parts and atmospheres should be free of chlorine and sulfur bearing compounds. For optimized solderability chip stock should be used promptly, preferably within 1.5 years of receipt.



Construction – Standard Termination

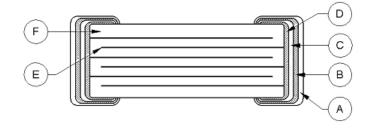
Reference	Ite	em	Material				
A		Finish	100% Matte Sn	SnPb (5% min)			
В	Termination System	Barrier Layer	Ni				
С	- ,	Base Metal	Cu				
D	Inner E	lectrode	Ni				
E	Dielectri	c Material	BaTiO ₃				



Note: Image is exaggerated in order to clearly identify all components of construction.

Construction – Flexible Termination

Reference	Item		Material		
A		Finish	100% Matte Sn	SnPb (5% min)	
В	Termination System	Barrier Layer	Ni		
С		Epoxy Layer	Ag		
D		Base Metal	Cu		
E	Inner Electrode		Ni		
F	Dielectri	c Material	BaTiO ₃		



Note: Image is exaggerated in order to clearly identify all components of construction.



10

Capacitor Marking (Optional):

These surface mount multilayer ceramic capacitors are normally supplied unmarked. If required, they can be marked as an extra cost option. Marking is available on most KEMET devices but must be requested using the correct ordering code identifier(s). If this option is requested, two sides of the ceramic body will be laser marked with a "K" to identify KEMET, followed by two characters (per EIA–198 - see table below) to identify the capacitance value. EIA 0603 case size devices are limited to the "K" character only. Marking appears in legible contrast. Illustrated below is an example of an MLCC with laser marking of "KA8", which designates a KEMET device with rated capacitance of 100 μ F. Orientation of marking is vendor optional.



Laser marking option is <u>not</u> available on:

- C0G, Ultra Stable X8R and Y5V dielectric devices
- EIA 0402 case size devices
- EIA 0603 case size devices with Flexible Termination option.
- · KPS Commercial and Automotive Grade stacked devices.

Capacitance (pF) For Various Alpha/Numeral Identifiers										
Alpho	Numeral									
Alpha	9	0	1	2	3	4	5	6	7	8
Character	Capacitance (pF)									
А	0.1	10	10	100	1,000	10,000	100,000	1,000,000	10,000,000	100,000,000
В	0.11	1.1	11	110	1,100	11,000	110,000	1,100,000	11,000,000	110,000,000
С	0.12	12	12	120	1,200	12,000	120,000	1,200,000	12,000,000	120,000,000
D	0.13	13	13	130	1,300	13,000	130,000	1,300,000	13,000,000	130,000,000
E	0.15	15	15	150	1,500	15,000	150,000	1,500,000	15,000,000	150,000,000
F	0.16	16	16	160	1,600	16,000	160,000	1,600,000	16,000,000	160,000,000
G	0.18	18	18	180	1,800	18,000	180,000	1,800,000	18,000,000	180,000,000
Н	0.2	20	20	200	2,000	20,000	200,000	2,000,000	20,000,000	200,000,000
J	0.22	22	22	220	2,200	22,000	220,000	2,200,000	22,000,000	220,000,000
К	0.24	2.4	24	240	2,400	24,000	240,000	2,400,000	24,000,000	240,000,000
L	0.27	2.7	27	270	2,700	27,000	270,000	2,700,000	27,000,000	270,000,000
М	0.3	30	30	300	3,000	30,000	300,000	3,000,000	30,000,000	300,000,000
Ν	0.33	33	33	330	3,300	33,000	330,000	3,300,000	33,000,000	330,000,000
Р	0.36	36	36	360	3,600	36,000	360,000	3,600,000	36,000,000	360,000,000
Q	0.39	39	39	390	3,900	39,000	390,000	3,900,000	39,000,000	390,000,000
R	0.43	4 3	43	430	4,300	43,000	430,000	4,300,000	43,000,000	430,000,000
S	0.47	4.7	47	470	4,700	47,000	470,000	4,700,000	47,000,000	470,000,000
Т	0.51	5.1	51	510	5,100	51,000	510,000	5,100,000	51,000,000	510,000,000
U	0.56	56	56	560	5,600	56,000	560,000	5,600,000	56,000,000	560,000,000
V	0.62	62	62	620	6,200	62,000	620,000	6,200,000	62,000,000	620,000,000
W	0.68	68	68	680	6,800	68,000	680,000	6,800,000	68,000,000	680,000,000
Х	0.75	75	75	750	7,500	75,000	750,000	7,500,000	75,000,000	750,000,000
Y	0.82	82	82	820	8,200	82,000	820,000	8,200,000	82,000,000	820,000,000
Z	0.91	9.1	91	910	9,100	91,000	910,000	9,100,000	91,000,000	910,000,000
а	0.25	2 5	25	250	2,500	25,000	250,000	2,500,000	25,000,000	250,000,000
b	0.35	3 5	35	350	3,500	35,000	350,000	3,500,000	35,000,000	350,000,000
d	0.4	4 0	40	400	4,000	40,000	400,000	4,000,000	40,000,000	400,000,000
e	0.45	4 5	45	450	4,500	45,000	450,000	4,500,000	45,000,000	450,000,000
f	0.5	50	50	500	5,000	50,000	500,000	5,000,000	50,000,000	500,000,000
m	0.6	60	60	600	6,000	60,000	600,000	6,000,000	60,000,000	600,000,000
n	0.7	70	70	700	7,000	70,000	700,000	7,000,000	70,000,000	700,000,000
t	0.8	80	80	800	8,000	80,000	800,000	8,000,000	80,000,000	800,000,000
у	0.9	90	90	900	9,000	90,000	900,000	9,000,000	90,000,000	900,000,000



Tape & Reel Packaging Information

KEMET offers multilayer ceramic chip capacitors packaged in 8, 12 and 16 mm tape on 7" and 13" reels in accordance with EIA Standard 481. This packaging system is compatible with all tape-fed automatic pick and place systems. See Table 2 for details on reeling quantities for commercial chips.

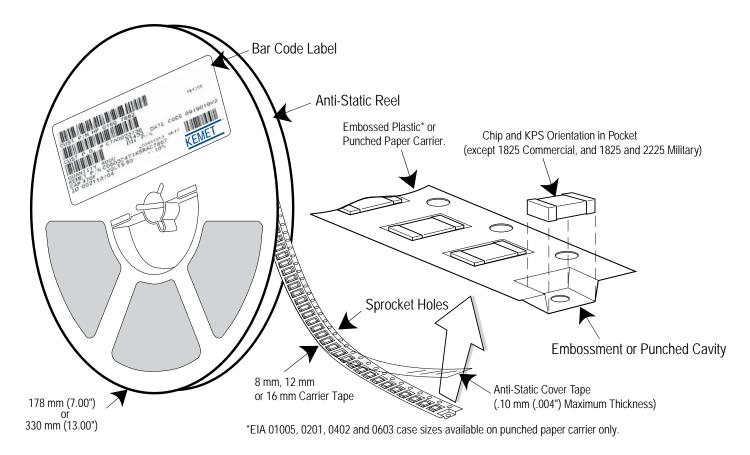


Table 5 – Carrier Tape Configuration – Embossed Plastic & Punched Paper (mm)

EIA Case Size	Tape Size (W)*	Pitch (P ₁)*
01005 – 0402	8	2
0603 – 1210	8	4
1805 – 1808	12	4
≥ 1812	12	8
KPS 1210	12	8
KPS 1812 & 2220	16	12
Array 0508 & 0612	8	4

*Refer to Figures 1 & 2 for W and P₁ carrier tape reference locations. *Refer to Tables 6 & 7 for tolerance specifications.



Figure 1 – Embossed (Plastic) Carrier Tape Dimensions

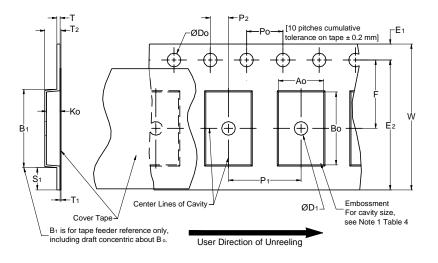


Table 6 – Embossed (Plastic) Carrier Tape Dimensions

Metric will govern

	Constant Dimensions — Millimeters (Inches)								
Tape Size	D ₀	D ₁ Minimum Note 1	E ₁	P ₀	P ₂	R Reference Note 2	S ₁ Minimum Note 3	T Maximum	T ₁ Maximum
8 mm		1.0 (0.039)				25.0 (0.984)			
12 mm	1.5 +0.10/-0.0 (0.059 +0.004/-0.0)	1.5	1.75 ±0.10 (0.069 ±0.004)	4.0 ±0.10 (0.157 ±0.004)	2.0 ±0.05 (0.079 ±0.002)	30	0.600 (0.024)	0.600 (0.024)	0.100 (0.004)
16 mm		(0.059)				(1.181)			
			Variable Dime	ensions — Mil	limeters (Inch	ies)			
Tape Size	Pitch	B ₁ Maximum Note 4	E ₂ Minimum	F	P ₁	T ₂ Maximum	W Maximum	A ₀ ,B ₀	& K ₀
8 mm	Single (4 mm)	4.35 (0.171)	6.25 (0.246)	3.5 ±0.05 (0.138 ±0.002)	4.0 ±0.10 (0.157 ±0.004)	2.5 (0.098)	8.3 (0.327)		
12 mm	Single (4 mm) & Double (8 mm)	8.2 (0.323)	10.25 (0.404)	5.5 ±0.05 (0.217 ±0.002)	8.0 ±0.10 (0.315 ±0.004)	4.6 (0.181)	12.3 (0.484)	Not	e 5
16 mm	Triple (12 mm)	12.1 (0.476)	14.25 (0.561)	7.5 ±0.05 (0.138 ±0.002)	12.0 ±0.10 (0.157 ±0.004)	4.6 (0.181)	16.3 (0.642)		

1. The embossment hole location shall be measured from the sprocket hole controlling the location of the embossment. Dimensions of embossment location and hole location shall be applied independent of each other.

2. The tape with or without components shall pass around R without damage (see Figure 6).

3. If S₁ < 1.0 mm, there may not be enough area for cover tape to be properly applied (see EIA Standard 481 paragraph 4.3 section b).

4. B, dimension is a reference dimension for tape feeder clearance only.

5. The cavity defined by A_{α} , B_{α} and K_{α} shall surround the component with sufficient clearance that:

(a) the component does not protrude above the top surface of the carrier tape.

(b) the component can be removed from the cavity in a vertical direction without mechanical restriction, after the top cover tape has been removed.

(c) rotation of the component is limited to 20° maximum for 8 and 12 mm tapes and 10° maximum for 16 mm tapes (see Figure 3).

(d) lateral movement of the component is restricted to 0.5 mm maximum for 8 and 12 mm wide tape and to 1.0 mm maximum for 16 mm tape (see Figure 4).

(e) for KPS Series product, A_{a} and B_{a} are measured on a plane 0.3 mm above the bottom of the pocket.

(f) see Addendum in EIA Standard 481 for standards relating to more precise taping requirements.



Figure 2 – Punched (Paper) Carrier Tape Dimensions

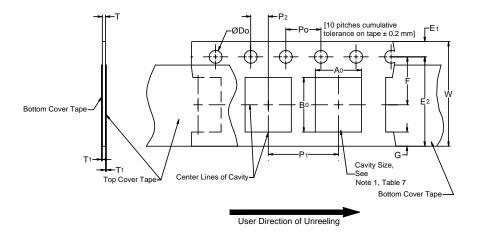


Table 7 – Punched (Paper) Carrier Tape Dimensions

Metric will govern

	Constant Dimensions — Millimeters (Inches)						
Tape Size	D ₀	E ₁	P ₀	P ₂	T ₁ Maximum	G Minimum	R Reference Note 2
8 mm	1.5 +0.10 -0.0 (0.059 +0.004 -0.0)	1.75 ±0.10 (0.069 ±0.004)	4.0 ±0.10 (0.157 ±0.004)	2.0 ±0.05 (0.079 ±0.002)	0.10 (0.004) Maximum	0.75 (0.030)	25 (0.984)
	Variable Dimensions — Millimeters (Inches)						
Tape Size	Pitch	E2 Minimum	F	P ₁	T Maximum	W Maximum	A ₀ B ₀
8 mm	Half (2 mm)	6.25	3.5 ±0.05	2.0 ±0.05 (0.079 ±0.002)	1.1	8.3 (0.327)	Note 1
8 mm	Single (4 mm)	(0.246)	(0.138 ±0.002)	4.0 ±0.10 (0.157 ±0.004)	(0.098)	8.3 (0.327)	NOLE I

1. The cavity defined by A_{ρ} , B_{ρ} and T shall surround the component with sufficient clearance that:

a) the component does not protrude beyond either surface of the carrier tape.

b) the component can be removed from the cavity in a vertical direction without mechanical restriction, after the top cover tape has been removed.

c) rotation of the component is limited to 20° maximum (see Figure 3).

d) lateral movement of the component is restricted to 0.5 mm maximum (see Figure 4).

e) see Addendum in EIA Standard 481 for standards relating to more precise taping requirements.

2. The tape with or without components shall pass around R without damage (see Figure 6).



Packaging Information Performance Notes

- 1. Cover Tape Break Force: 1.0 Kg minimum.
- 2. Cover Tape Peel Strength: The total peel strength of the cover tape from the carrier tape shall be:

Tape Width	Peel Strength
8 mm	0.1 to 1.0 Newton (10 to 100 gf)
12 and 16 mm	0.1 to 1.3 Newton (10 to 130 gf)

The direction of the pull shall be opposite the direction of the carrier tape travel. The pull angle of the carrier tape shall be 165° to 180° from the plane of the carrier tape. During peeling, the carrier and/or cover tape shall be pulled at a velocity of 300 ± 10 mm/minute. 3. Labeling: Bar code labeling (standard or custom) shall be on the side of the reel opposite the sprocket holes. *Refer to EIA Standards* 556 and 624.

Figure 3 – Maximum Component Rotation

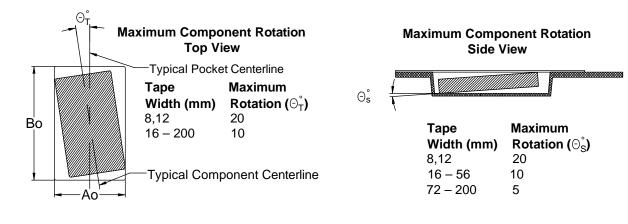


Figure 4 – Maximum Lateral Movement

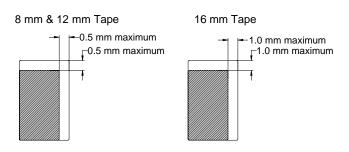


Figure 5 – Bending Radius

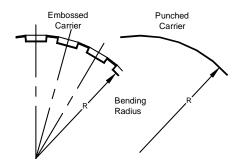
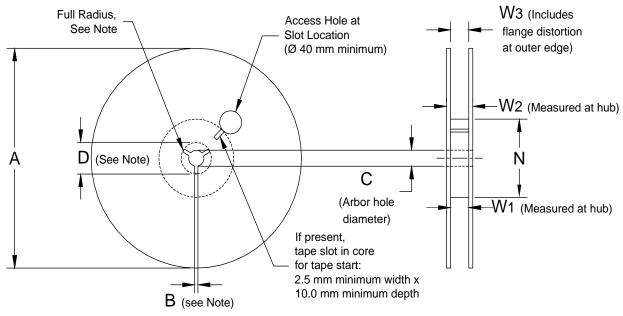




Figure 6 – Reel Dimensions



Note: Drive spokes optional; if used, dimensions B and D shall apply.

Table 8 – Reel Dimensions

Metric will govern

	Constant Dimensions — Millimeters (Inches)						
Tape Size	А	B Minimum	С	D Minimum			
8 mm	178 ±0.20						
12 mm	(7.008 ±0.008)	1.5 (0.059)	13.0 +0.5/-0.2 (0.521 +0.02/-0.008)	20.2 (0.795)			
16 mm	330 ±0.20 (13.000 ±0.008)		()	()			
	Variable	Dimensions — Millimeter	rs (Inches)				
Tape Size	N Minimum	W ₁	W ₂ Maximum	W ₃			
8 mm		8.4 +1.5/-0.0 (0.331 +0.059/-0.0)	14.4 (0.567)				
12 mm	50 (1.969)	12.4 +2.0/-0.0 (0.488 +0.078/-0.0)	18.4 (0.724)	Shall accommodate tape width without interference			
16 mm		16.4 +2.0/-0.0 (0.646 +0.078/-0.0)	22.4 (0.882)				



Figure 7 – Tape Leader & Trailer Dimensions

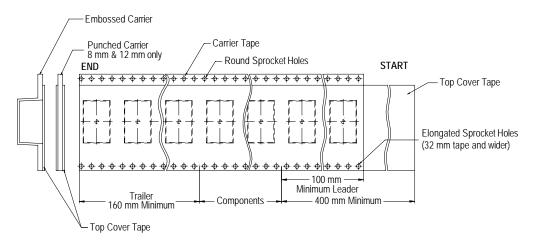
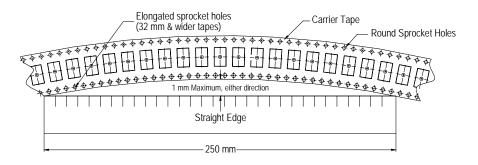


Figure 8 – Maximum Camber





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